


<b>Search Notes</b>  	<b>Application/Control No.</b>  10644276	<b>Applicant(s)/Patent Under Reexamination</b>  RAO ET AL.
	<b>Examiner</b>  DJENANE M BAYARD	<b>Art Unit</b>  2141

SEARCHED			
Class	Subclass	Date	Examiner
705	10	8/28/08	db
455	466	8/28/08	db

SEARCH NOTES		
Search Notes	Date	Examiner
east	8/28/08	db

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner